Search Notes

Application/Control No.	Applicant(s)/Pate Reexamination	ent under
10/075,027	AOKI, YOSHIKA	\ZU
Examiner	Art Unit	
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	SEAR	CHED	
Class	Subclass	Date	Examiner
. 370	237 updated	3/1/2007	НМ
370	346	3/1/2007	нм
370	449-451	3/1/2007	НМ
718	105	3/1/2007	НМ
710	15-19	3/1/2007	НМ
710	44,46	3/1/2007	НМ
709	223-225	3/1/2007	нм
370	346	3/1/2007	нм
370	449	3/1/2007	НМ
370	451-457	3/1/2007	нм
379	92.01	3/1/2007	НМ
709	223-225	3/1/2007	НМ
725	16	3/1/2007	НМ
710	44,46,210	3/1/2007	НМ

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Searched EAST DB: USPG-PUB, USPAT, EPO, and JPO	3/1/2007	НМ		
IEEE	3/1/2007	НМ		
Palm's Inventor DB	7/20/2006	НМ		
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